Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
‖‖‖‖‖‖‖‖‖‖‖‖‖‖	10/659,974	KRYZAK ET AL.
	Examiner	Art Unit	
	Ted M. Wang	2611	

SEARCHED			
Class	Subclass	Date	Examiner
375	219, 220, 222	12/6/2007	TW
370	535	12/6/2007	TW
455	73, 88	12/6/2007	TW
455	507	12/6/2007	TW

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST - USPGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB, see attached search report	12/6/2007	TW
ODP- searched and reviewed.	12/6/2007	TW
Inventor search - (Kryzak with (Joseph or Neil)) or (Hoelscher with Aaron) or (Rock with Thomas)	12/6/2007	TW
IEEE- Author - Kryzak J. and Hoelscher A. and Rock T. and Kryzak J. N.	12/6/2007	TW
IEEExplor - Advance search - Bond* (code or sequence) and transceiver and master and slave and detect and delay	12/6/2007	TW

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
375	219, 220	12/6/2007	TW
375	222	12/6/2007	TW
370	535	12/6/2007	TW
455/73, 88, 507		12/6/2007	TW